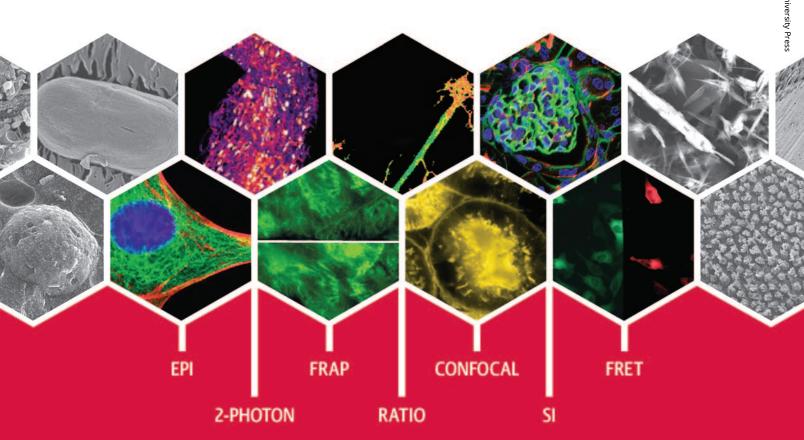


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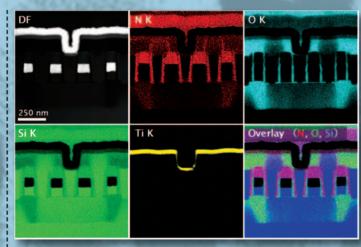
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Unrivaled EDS for TEM

0.98sr 100mm²

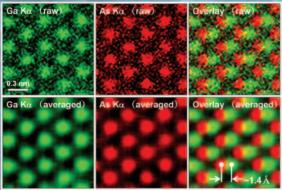
- Exponentially enhances elemental mapping for nano-area analysis TEM
- · Automatic retractable design



High sensitivity for fast mapping at atomic resolution

Seamless chemical mapping and data collection for S/TEM-TEM-SEM-EDS. (256 x 256 pixels.

Total acquisition time: 1 min. 13 sec.)



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